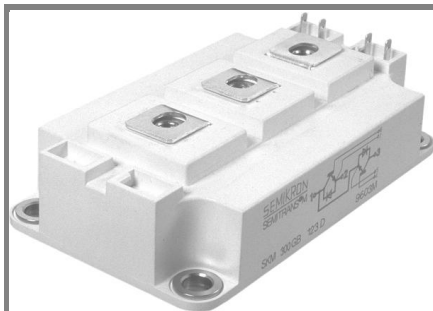


# SKM 300GB128D



SEMITRANS™ 3

## SPT IGBT Module

SKM 300GB128D

SKM 300GAL128D

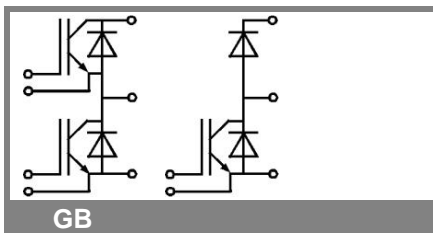
Preliminary Data

### Features

- Homogeneous Si
- SPT = Soft-Punch-Through technology
- $V_{CEsat}$  with positive temperature coefficient
- High short circuit capability, self limiting to  $6 \times I_C$

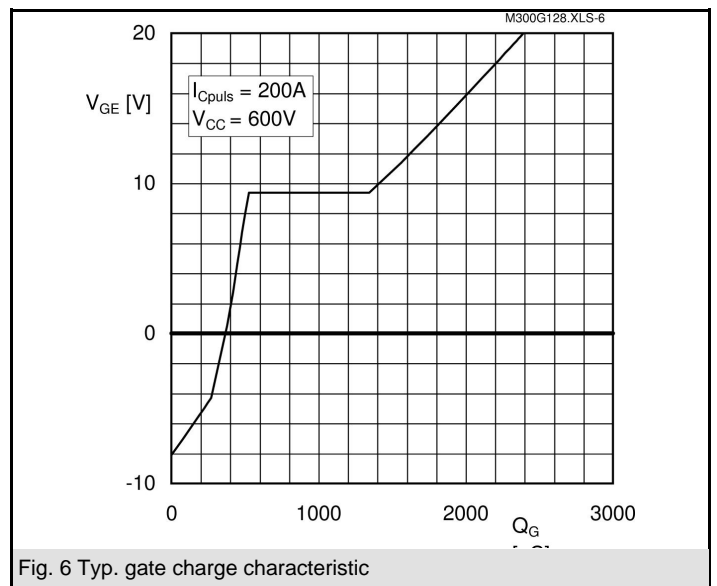
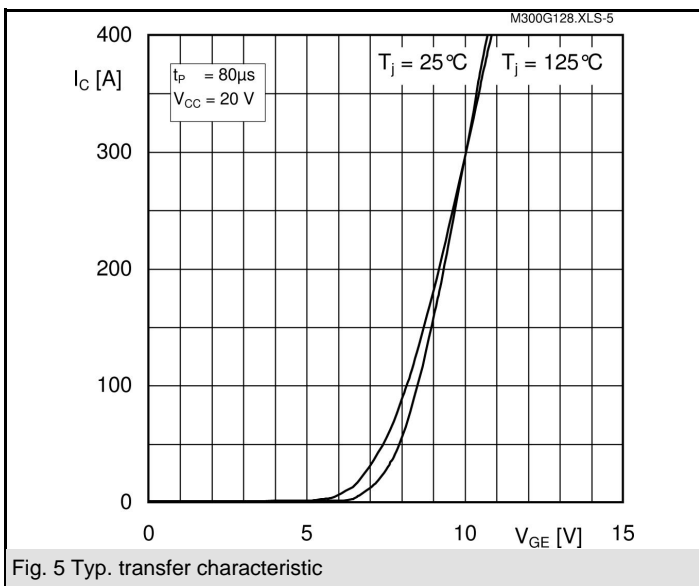
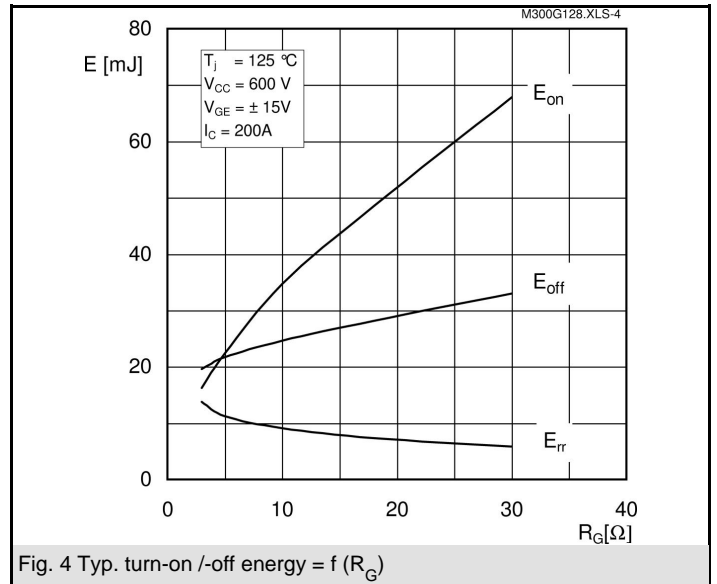
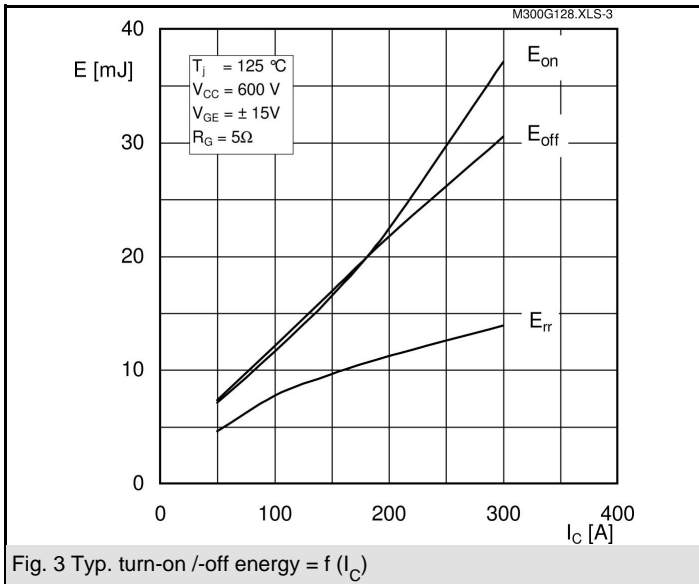
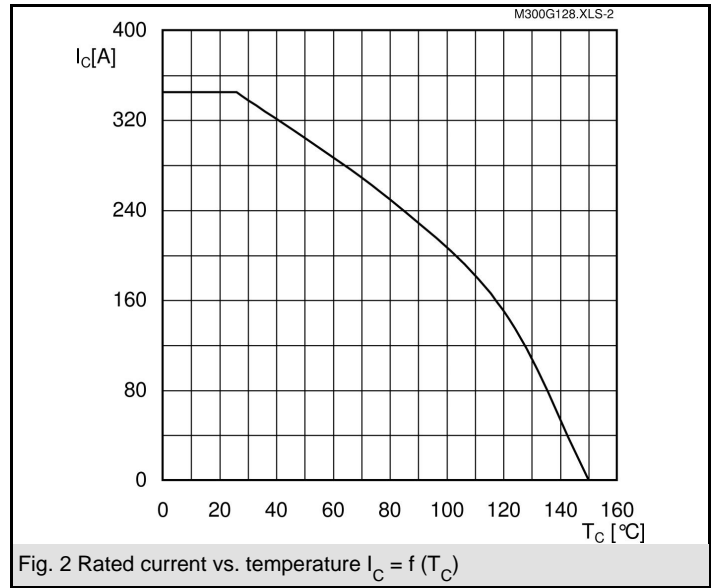
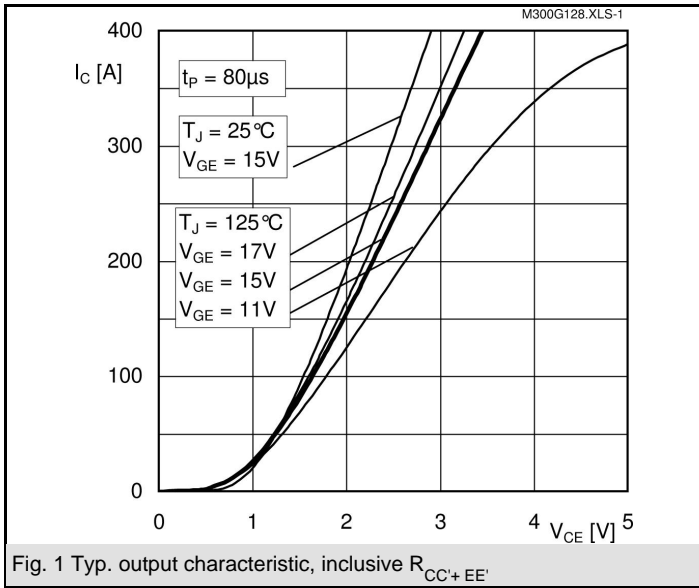
### Typical Applications

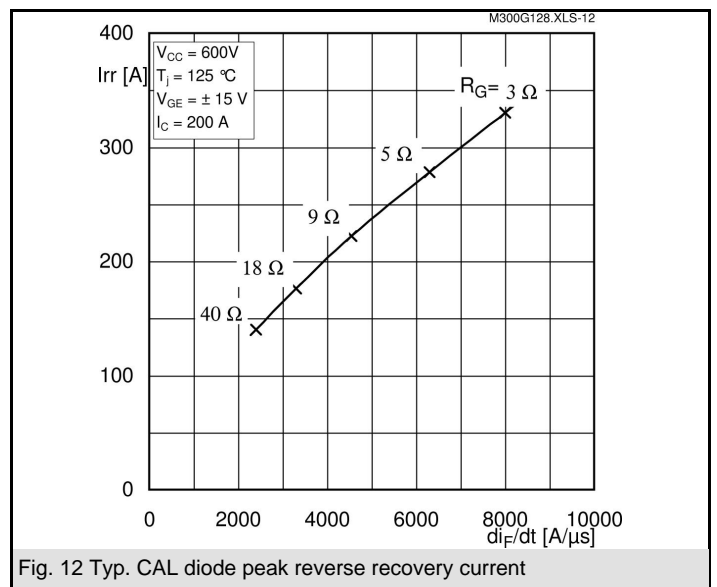
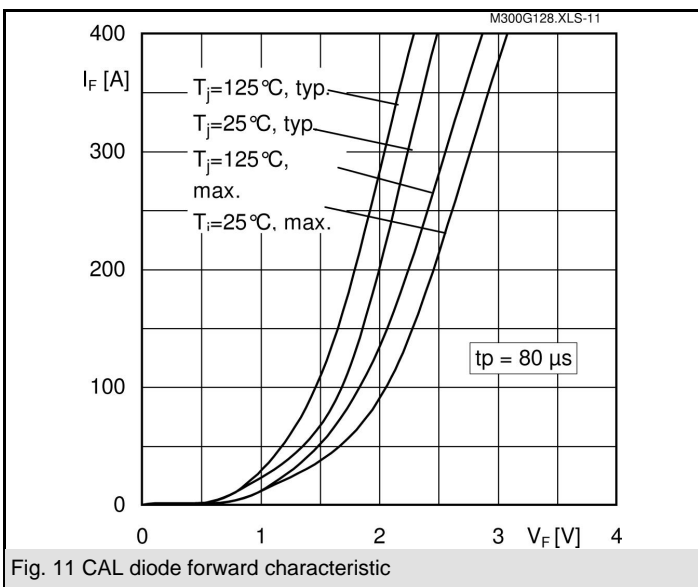
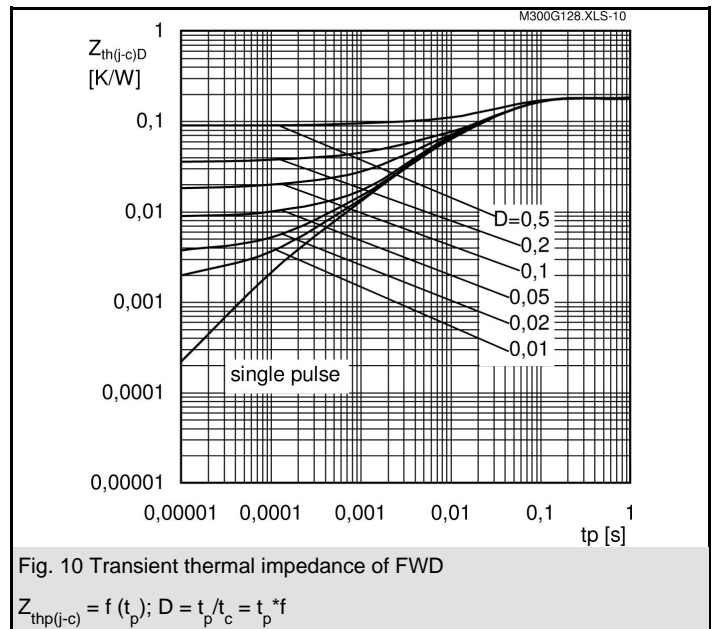
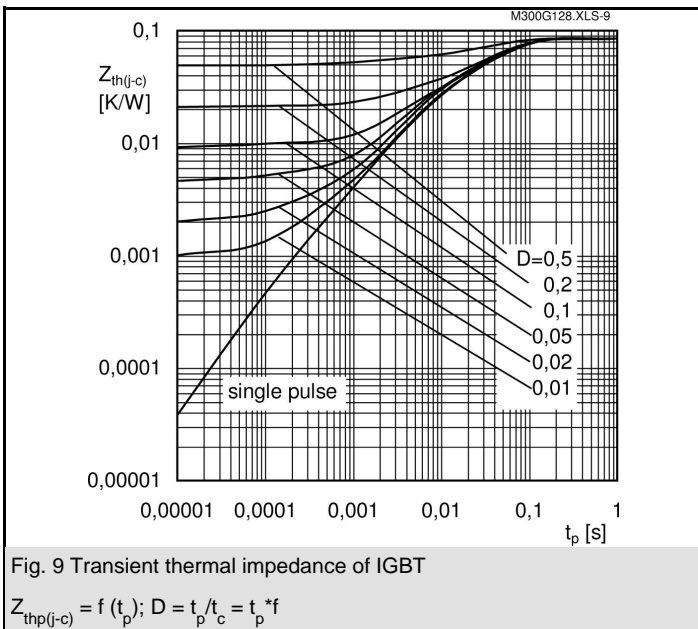
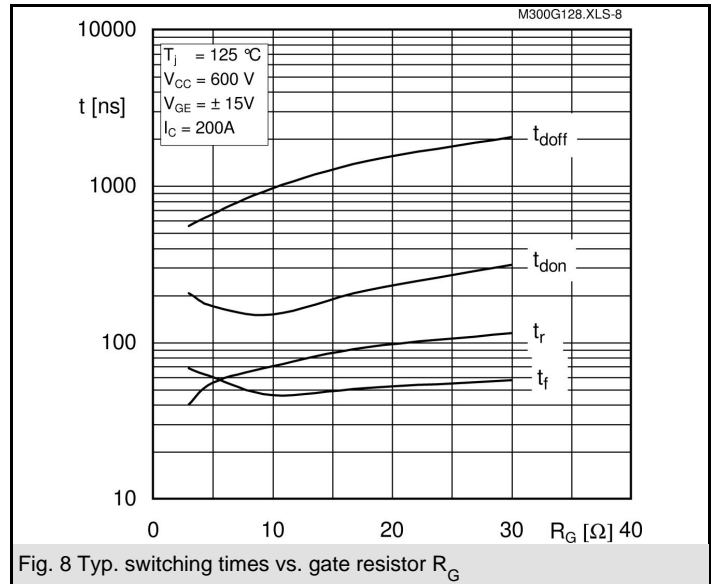
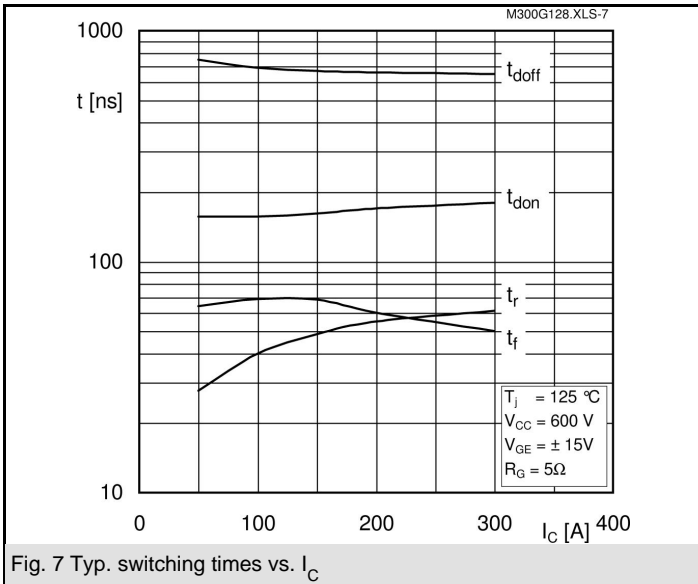
- AC inverter drives
- UPS
- Electronic welders at  $f_{sw} > 20$  kHz



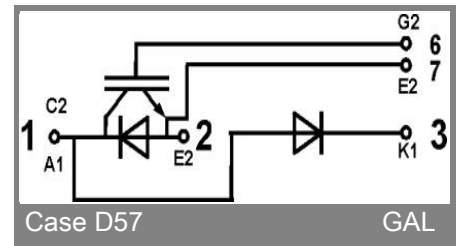
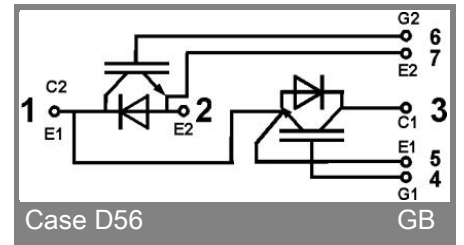
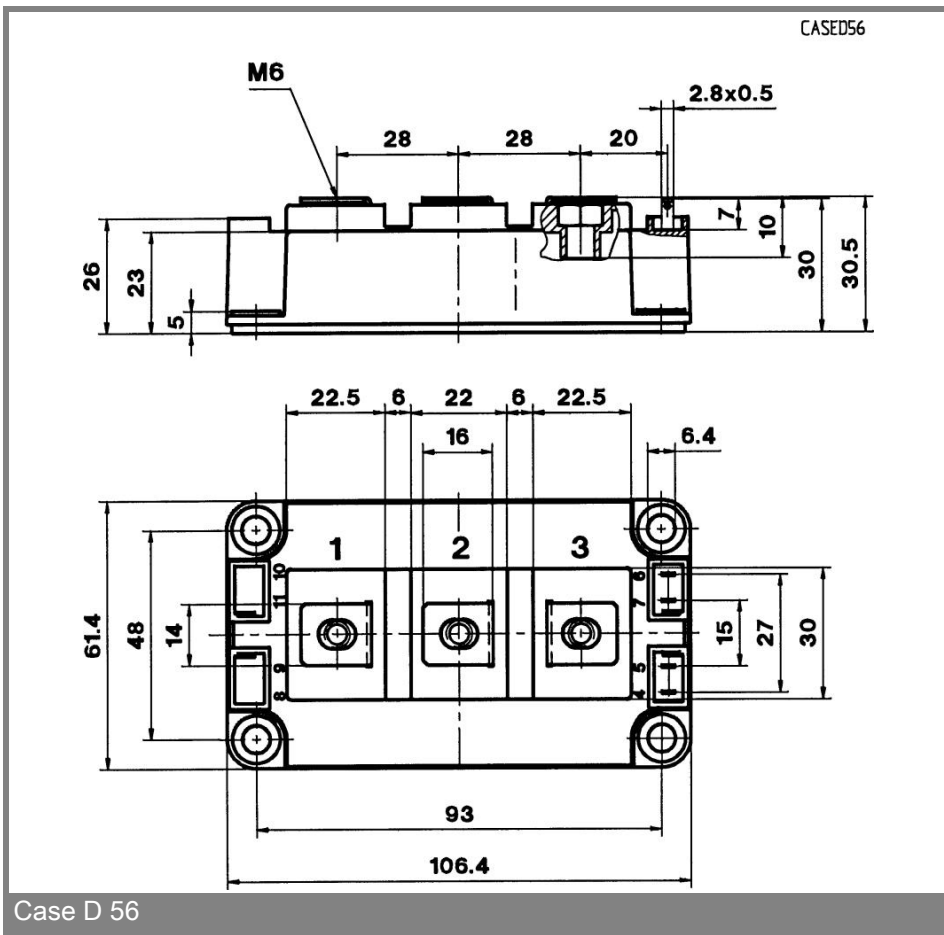
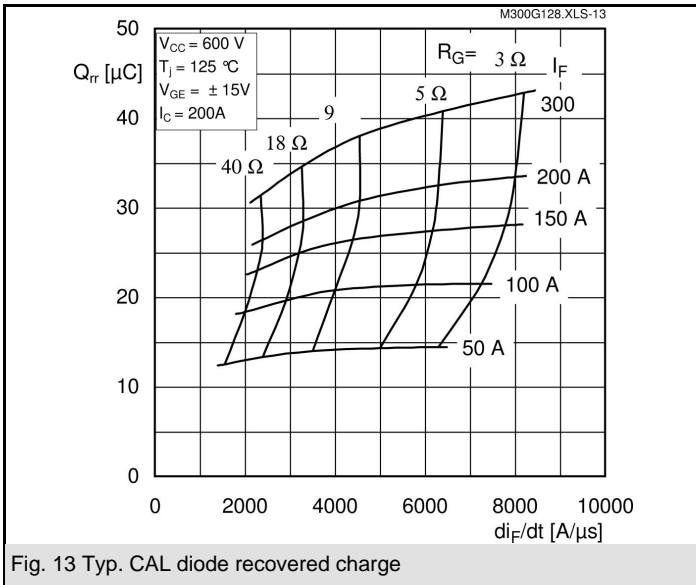
| Absolute Maximum Ratings  |   | $T_C = 25^\circ\text{C}$ , unless otherwise specified |                  |
|---------------------------|---|---|------------------|
| Symbol                    | Conditions  | Values  | Units            |
| <b>IGBT</b>               |   |   |                  |
| $V_{CES}$                 |   | 1200  | V                |
| $I_C$                     | $T_{case} = 25 (80)^\circ\text{C}$                | 345 (250)   | A                |
| $I_{CRM}$                 | $T_{case} = 25 (80)^\circ\text{C}$ , $t_p = 1$ ms | 690 (500)   | A                |
| $V_{GES}$                 |   | $\pm 20$  | V                |
| $T_{vj}$ ( $T_{stg}$ )    | $T_{OPERATION} \leq T_{stg}$                      | - 40 ... + 150 (125)                                  | $^\circ\text{C}$ |
| $V_{isol}$                | AC, 1 min.  | 4000  | V                |
| <b>Inverse diode</b>      |   |   |                  |
| $I_F = -I_C$              | $T_{case} = 25 (80)^\circ\text{C}$                | 260 (180)   | A                |
| $I_{FRM}$                 | $T_{case} = 25 (80)^\circ\text{C}$ , $t_p = 1$ ms | 690 (500)   | A                |
| $I_{FSM}$                 | $t_p = 10$ ms; sin.; $T_j = 150^\circ\text{C}$    | 2200  | A                |
| <b>Freewheeling diode</b> |   |   |                  |
| $I_F = -I_C$              | $T_{case} = 25 (80)^\circ\text{C}$                | 260 (180)   | A                |
| $I_{FRM}$                 | $T_{case} = 25 (80)^\circ\text{C}$ , $t_p = 1$ ms | 690 (500)   | A                |
| $I_{FSM}$                 | $t_p = 10$ ms; sin.; $T_j = 150^\circ\text{C}$    | 2200  | A                |

| Characteristics                |  | $T_C = 25^\circ\text{C}$ , unless otherwise specified |            |       |               |
|--------------------------------|--|---|------------|-------|---------------|
| Symbol                         | Conditions   | min.  | typ.       | max.  | Units         |
| <b>IGBT</b>                    |  |   |            |       |               |
| $V_{GE(th)}$                   | $V_{GE} = V_{CE}$ , $I_C = 8$ mA                                   | 4,5   | 5,5        | 6,5   | V             |
| $I_{CES}$                      | $V_{GE} = 0$ , $V_{CE} = V_{CES}$ , $T_j = 25 (125)^\circ\text{C}$ |   |            | 2     | mA            |
| $V_{CE(TO)}$                   | $T_j = 25 (125)^\circ\text{C}$                                     |   | 1 (0,9)    | 1,15  | V             |
| $r_{CE}$                       | $V_{GE} = 15$ V, $T_j = 25 (125)^\circ\text{C}$                    |   | 5 (7)      | 6,3   | m $\Omega$    |
| $V_{CE(sat)}$                  | $I_C = 200$ A, $V_{GE} = 15$ V, chip level                         |   | 2 (2,3)    | 2,4   | V             |
| $C_{ies}$                      | under following conditions   |   | 17         |       | nF            |
| $C_{oes}$                      | $V_{GE} = 0$ , $V_{CE} = 25$ V, $f = 1$ MHz                        |   | 2          |       | nF            |
| $C_{res}$                      |  |   | 1,9        |       | nF            |
| $L_{CE}$                       |  |   |            | 20    | nH            |
| $R_{CC'+EE'}$                  | resistance, terminal-chip $T_C = 25 (125)^\circ\text{C}$           |   | 0,35 (0,5) |       | m $\Omega$    |
| $t_{d(on)}$                    | $V_{CC} = 600$ V, $I_C = 200$ A                                    |   | 170        |       | ns            |
| $t_r$                          | $R_{Gon} = R_{Goff} = 5 \Omega$ , $T_j = 125^\circ\text{C}$        |   | 55         |       | ns            |
| $t_{d(off)}$                   | $V_{GE} = \pm 15$ V  |   | 660        |       | ns            |
| $t_f$                          |  |   | 60         |       | ns            |
| $E_{on} (E_{off})$             |  |   | 22 (22)    |       | mJ            |
| <b>Inverse diode</b>           |  |   |            |       |               |
| $V_F = V_{EC}$                 | $I_F = 200$ A; $V_{GE} = 0$ V; $T_j = 25 (125)^\circ\text{C}$      |   | 2 (1,8)    | 2,5   | V             |
| $V_{T(TO)}$                    | $T_j = 25 (125)^\circ\text{C}$                                     |   | 1,1        | 1,2   | V             |
| $r_T$                          | $T_j = 25 (125)^\circ\text{C}$                                     |   | 4,5        | 6,5   | m $\Omega$    |
| $I_{RRM}$                      | $I_F = 200$ A; $T_j = 125 ( )^\circ\text{C}$                       |   | 280        |       | A             |
| $Q_{rr}$                       | $di/dt = 6300$ A/ $\mu\text{s}$                                    |   | 33         |       | $\mu\text{C}$ |
| $E_{rr}$                       | $V_{GE} = 0$ V   |   | 11         |       | mJ            |
| <b>FWD</b>                     |  |   |            |       |               |
| $V_F = V_{EC}$                 | $I_F = 200$ A; $V_{GE} = 0$ V, $T_j = 25 (125)^\circ\text{C}$      |   | 2 (1,8)    | 2,5   | V             |
| $V_{TO}$                       | $T_j = 25 (125)^\circ\text{C}$                                     |   | 1,1        | 1,2   | V             |
| $r_T$                          | $T_j = 25 (125)^\circ\text{C}$                                     |   | 4,5        | 6,5   | m $\Omega$    |
| $I_{RRM}$                      | $I_F = 200$ A; $T_j = 25 (125)^\circ\text{C}$                      |   | 280        |       | A             |
| $Q_{rr}$                       | $V_{GE} = 0$ V   |   | 33         |       | $\mu\text{C}$ |
| $E_{rr}$                       |  |   | 11         |       | mJ            |
| <b>Thermal characteristics</b> |  |   |            |       |               |
| $R_{th(j-c)}$                  | per IGBT   |   |            | 0,085 | K/W           |
| $R_{th(j-c)D}$                 | per Inverse Diode  |   |            | 0,18  | K/W           |
| $R_{th(j-c)FD}$                | per FWD  |   |            |       | K/W           |
| $R_{th(c-s)}$                  | per module   |   |            | 0,038 | K/W           |
| <b>Mechanical data</b>         |  |   |            |       |               |
| $M_s$                          | to heatsink (M6)   | 3   |            | 5     | Nm            |
| $M_t$                          | for terminals (M5)   | 2,5   |            | 5     | Nm            |
| w                              |  |   |            | 325   | g             |





# SKM 300GB128D



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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